



## N-Channel 30 V (D-S) MOSFET

PRODUCT SUMMARY							
V <sub>DS</sub> (V)	R <sub>DS(on)</sub> (Ω) MAX.	I <sub>D</sub> (A) <sup>a</sup>	Q <sub>g</sub> (TYP.)				
30	0.095 at V <sub>GS</sub> = 4.5 V	2.5					
	0.105 at V <sub>GS</sub> = 2.5 V	2.3	3.7 nC				
	0.120 at V <sub>GS</sub> = 1.8 V	2.2					
	0.165 at V <sub>GS</sub> = 1.5 V	1.9					

# MICRO FOOT® 0.8 x 0.8 **Backside View Bump Side View**

Marking Code: xx = AI

xxx = Date/Lot traceability code

**Ordering Information:** 

Si8808DB-T2-E1 (lead (Pb)-free and halogen-free)

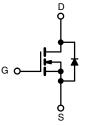
#### **FEATURES**

- TrenchFET® power MOSFET
- Small 0.8 mm x 0.8 mm outline area
- Low 0.4 mm max. profile
- 30 V max. rating and low on-resistance
- · Material categorization: for definitions of compliance please see www.vishay.com/doc?99912

RoHS HALOGEN FREE

#### **APPLICATIONS**

- · Load switch
- · High speed switching
- DC/DC converters
- For smart phones, tablet PCs, and mobile computing



N-Channel MOSFET

<b>ABSOLUTE MAXIMUM RATING</b>	<b>S</b> (T <sub>A</sub> = 25 °C, u	ınless otherw	rise noted)		
PARAMETER		SYMBOL	LIMIT	UNIT	
Drain-Source Voltage		V <sub>DS</sub>	30	V	
Gate-Source Voltage		V <sub>GS</sub>	± 8	v	
	T <sub>A</sub> = 25 °C		2.5 <sup>a</sup>		
Continuous Drain Current (T. 150 °C)	T <sub>A</sub> = 70 °C	Ι, Γ	2 <sup>a</sup>		
Continuous Drain Current (T <sub>J</sub> = 150 °C)	T <sub>A</sub> = 25 °C	l <sub>D</sub>	1.8 <sup>b</sup>		
	T <sub>A</sub> = 70 °C	Ţ [	1.4 b	Α	
Pulsed Drain Current (t = 300 μs)		I <sub>DM</sub>	10	1	
Continuous Courses Drain Diade Current	T <sub>A</sub> = 25 °C	,	0.7 <sup>a</sup>		
Continuous Source-Drain Diode Current	T <sub>A</sub> = 25 °C	l <sub>S</sub>	0.4 b		
	T <sub>A</sub> = 25 °C		0.9 <sup>a</sup>		
Mayimum Dawar Dissination	T <sub>A</sub> = 70 °C	1 , [	0.6 <sup>a</sup>	w	
Maximum Power Dissipation	T <sub>A</sub> = 25 °C	P <sub>D</sub>	0.5 b	VV	
	T <sub>A</sub> = 70 °C	1	0.3 b	1	
Operating Junction and Storage Temperatur	re Range	T <sub>J</sub> , T <sub>stg</sub>	-55 to +150	°C	
Soldering Recommendations (Peak Tempera	ature) <sup>c</sup>		260		

THERMAL RESISTANCE RATINGS							
PARAMETER		SYMBOL	TYPICAL	MAXIMUM	UNIT		
Maximum Junction-to-Ambient a,d	+ < F o	В	105	135	°C/W		
Maximum Junction-to-Ambient b,e	t ≤ 5 s	R <sub>thJA</sub>	200	260			

- a. Surface mounted on 1" x 1" FR4 board with full copper, t = 5 s.
- b. Surface mounted on 1" x 1" FR4 board with minimum copper, t = 5 s.
- c. Refer to IPC/JEDEC® (J-STD-020), no manual or hand soldering.
- d. Maximum under steady state conditions is 185 °C/W.
- e. Maximum under steady state conditions is 330 °C/W.

## Vishay Siliconix

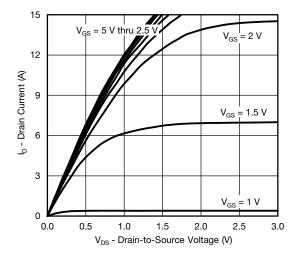
PARAMETER	SYMBOL	MIN.	TYP.	MAX.	UNIT			
Static		TEST CONDITIONS	1	1		1		
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 250 μA	30	_	_	V		
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	ne/Tu		31	-			
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I <sub>D</sub> = 250 μA	_	-2.3	-	mV/°C		
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	0.4	-	0.9	V		
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 8 \text{ V}$	-	-	± 100	nA		
Ţ.	400	V <sub>DS</sub> = 30 V, V <sub>GS</sub> = 0 V	_	-	1			
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 30 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 55 °C	-	-	10	μΑ		
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge 5 \text{ V}, V_{GS} = 4.5 \text{ V}$	5	-	-	Α		
	2(0.1)	V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 1 A	-	0.071	0.095	1		
	_	V <sub>GS</sub> = 2.5 V, I <sub>D</sub> = 1 A	_	0.079	0.105	Ω		
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	V <sub>GS</sub> = 1.8 V, I <sub>D</sub> = 1 A	_	0.090	0.120			
		V <sub>GS</sub> = 1.5 V, I <sub>D</sub> = 0.5 A	-	0.105	0.165			
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = 15 V, I <sub>D</sub> = 1 A	-	10	-	S		
Dynamic <sup>b</sup>	0.0	, , ,	ı		l			
Input Capacitance	C <sub>iss</sub>		-	330	_	pF		
Output Capacitance	Coss	V <sub>DS</sub> = 15 V, V <sub>GS</sub> = 0 V, f = 1 MHz	-	40	-			
Reverse Transfer Capacitance	C <sub>rss</sub>		-	16	-			
		V <sub>DS</sub> = 15 V, V <sub>GS</sub> = 8 V, I <sub>D</sub> = 1 A	-	6.5	10	nC		
Total Gate Charge	Q <sub>g</sub> Q <sub>gs</sub> Q <sub>gd</sub>	3.0	-	3.7	5.6			
Gate-Source Charge		$V_{DS} = 15 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 1 \text{ A}$	-	0.53	-			
Gate-Drain Charge			-	0.52	-			
Gate Resistance	Ra	f = 1 MHz	-	3.1	-	Ω		
Turn-On Delay Time	t <sub>d(on)</sub>		-	5	10			
Rise Time	t <sub>r</sub>	$V_{DD} = 15 \text{ V}, R_{L} = 15 \Omega$	-	12	25	- - -		
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong 1 \text{ A}, V_{GEN} = 8 \text{ V}, R_g = 1 \Omega$	-	15	30			
Fall Time	t <sub>f</sub>		-	6	15			
Turn-On Delay Time	t <sub>d(on)</sub>		-	7	15	ns		
Rise Time	t <sub>r</sub>	$V_{DD} = 15 \text{ V}, R_{L} = 15 \Omega$	-	15	30	1		
Turn-Off Delay Time	t <sub>d(off)</sub>	1 1 4 4 7 4 5 7 5 1 6		22	40	1		
Fall Time	t <sub>f</sub>		-	10	20			
Drain-Source Body Diode Characteristic	:S				l			
Continuous Source-Drain Diode Current	I <sub>S</sub>	T <sub>A</sub> = 25 °C	-	-	0.7			
Pulse Diode Forward Current	I <sub>SM</sub>		-	-	10	A		
Body Diode Voltage	V <sub>SD</sub>	I <sub>S</sub> = 1 A, V <sub>GS</sub> = 0 V	-	0.7	1.2	V		
Body Diode Reverse Recovery Time	t <sub>rr</sub>		-	11	20	ns		
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>		-	5	10	nC		
Reverse Recovery Fall Time	ta	$I_F = 1 \text{ A, dI/dt} = 100 \text{ A/}\mu\text{s, T}_J = 25 ^{\circ}\text{C}$	-	7	-	ns		
Reverse Recovery Rise Time	t <sub>b</sub>		-	4	-			

#### Notes

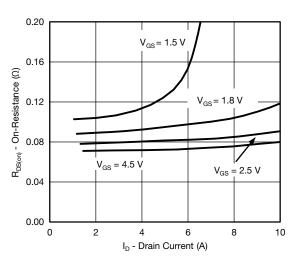
- a. Pulse test; pulse width  $\leq 300~\mu s,~duty~cycle \leq 2~\%.$
- b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

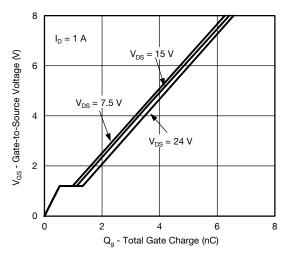




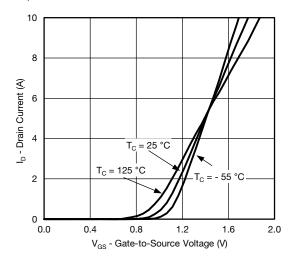
#### **Output Characteristics**



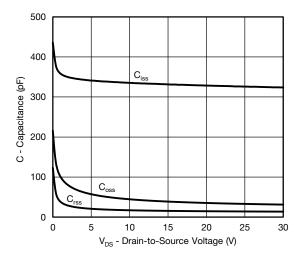
On-Resistance vs. Drain Current



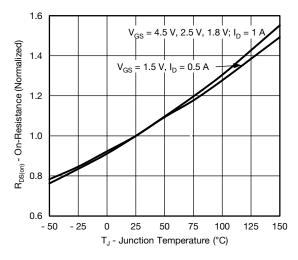
**Gate Charge** 



**Transfer Characteristics** 

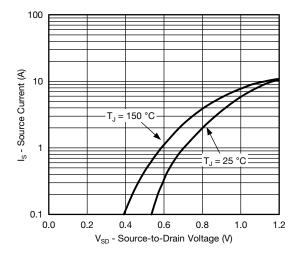


Capacitance

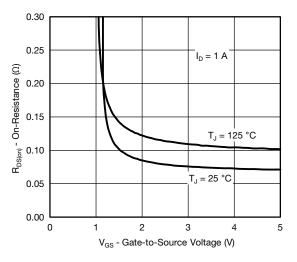


On-Resistance vs. Junction Temperature

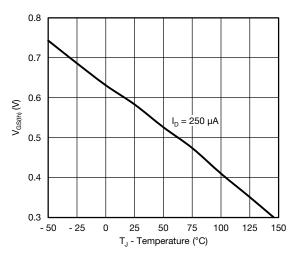




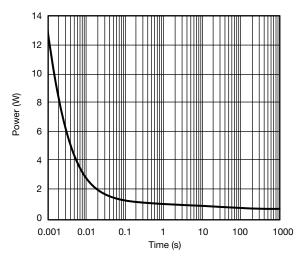
Source-Drain Diode Forward Voltage



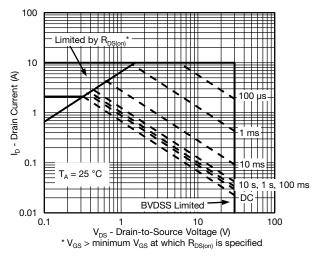
On-Resistance vs. Gate-to-Source Voltage



**Threshold Voltage** 

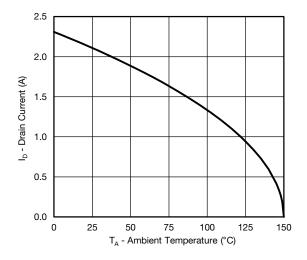


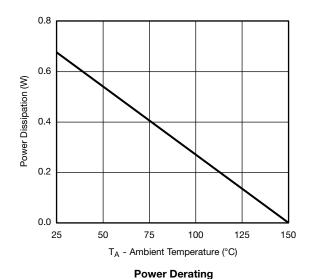
Single Pulse Power (Junction-to-Ambient)



Safe Operating Area, Junction-to-Ambient







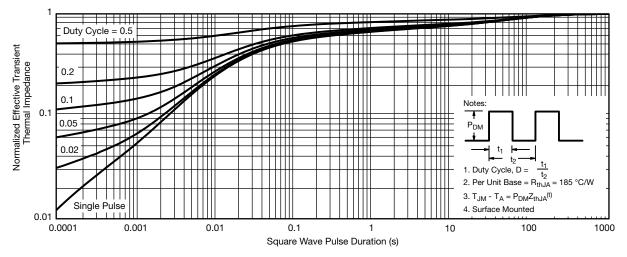
**Current Derating\*** 

Note

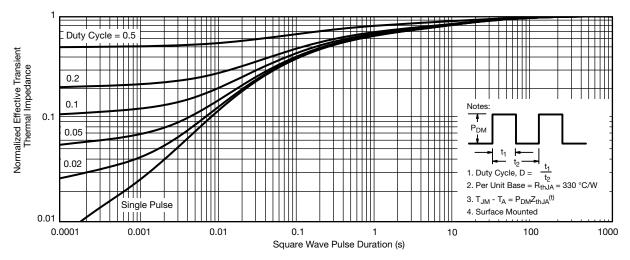
When mounted on 1" x 1" FR4 with full copper.

<sup>\*</sup> The power dissipation P<sub>D</sub> is based on T<sub>J (max.)</sub> = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





Normalized Thermal Transient Impedance, Junction-to-Ambient (On 1" x 1" FR4 Board with Maximum Copper)

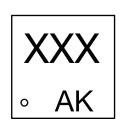


Normalized Thermal Transient Impedance, Junction-to-Ambient (On 1" x 1" FR4 Board with Minimum Copper)

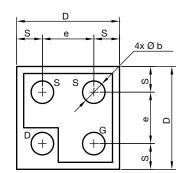
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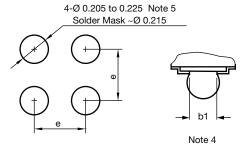
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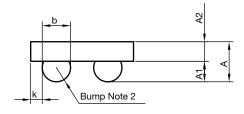
# MICRO FOOT®: 4-Bump (0.8 mm x 0.8 mm, 0.4 mm Pitch)



Mark on Backside of die







#### Notes

- (1) Laser mark on the backside surface of die
- (2) Bumps are 95.5 % Sn,3.8 % Ag,0.7 % Cu
- (3) "i" is the location of pin 1
- (4) "b1" is the diameter of the solderable substrate surface, defined by an opening in the solder resist layer solder mask defined.
- (5) Non-solder mask defined copper landing pad.

DIM.	MILLIMETERS a			INCHES		
	MIN.	NOM.	MAX.	MIN.	NOM.	MAX.
Α	0.328	0.365	0.402	0.0129	0.0144	0.0158
A1	0.136	0.160	0.184	0.0053	0.0062	0.0072
A2	0.192	0.205	0.218	0.0076	0.0081	0.0086
b	0.200	0.220	0.240	0.0078	0.0086	0.0094
b1	0.175			0.0068		
е	0.400			0.0157		
S	0.160	0.180	0.200	0.0062	0.0070	0.0078
D	0.720	0.760	0.800	0.0283	0.0299	0.0314
K	0.040	0.070	0.100	0.0015	0.0027	0.0039

#### Note

a. Use millimeters as the primary measurement.

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Revision: 16-Feb-15 1 Document Number: 69442



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